Bilateral switch Rev. 1 — 1 August 2012

General description 1.

The 74LVC1G66-Q100 provides one single pole, single-throw analog switch function. It has two input/output terminals (Y and Z) and an active HIGH enable input pin (E). When E is LOW, the analog switch is turned off.

Schmitt trigger action at the enable input makes the circuit tolerant of slower input rise and fall times across the entire V_{CC} range from 1.65 V to 5.5 V.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

Features and benefits 2.

- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
 - Specified from –40 °C to +85 °C and from –40 °C to +125 °C
- Wide supply voltage range from 1.65 V to 5.5 V
- Very low ON resistance:
 - 7.5 Ω (typical) at V_{CC} = 2.7 V
 - 6.5 Ω (typical) at V_{CC} = 3.3 V
 - 6 Ω (typical) at V_{CC} = 5 V
- Switch current capability of 32 mA
- High noise immunity
- CMOS low power consumption
- TTL interface compatibility at 3.3 V
- Latch-up performance meets requirements of JESD78 Class I
- ESD protection:
 - MIL-STD-883, method 3015 exceeds 2000 V
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V (C = 200 pF, R = 0 Ω)
- Enable input accepts voltages up to 5.5 V
- Multiple package options



3. Ordering information

Table 1. Ordering in	nformation			
Type number	Package			
	Temperature range	Name	Description	Version
74LVC1G66GW-Q100	–40 °C to +125 °C	TSSOP5	plastic thin shrink small outline package; 5 leads; body width 1.25 mm	SOT353-1
74LVC1G66GV-Q100	–40 °C to +125 °C	SC-74A	plastic surface-mounted package; 5 leads	SOT753

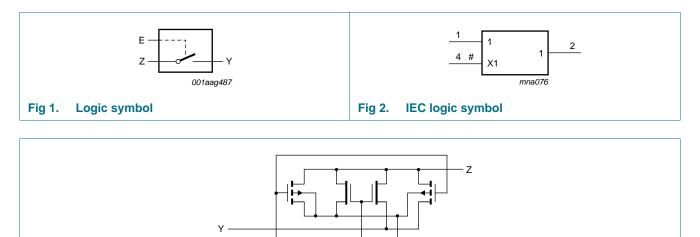
4. Marking

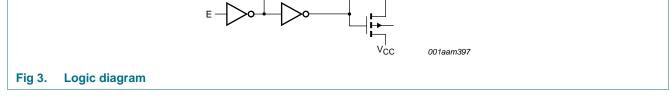
Table 2.	Marking
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Type number	Marking code ^[1]
74LVC1G66GW-Q100	VL
74LVC1G66GV-Q100	V66

[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

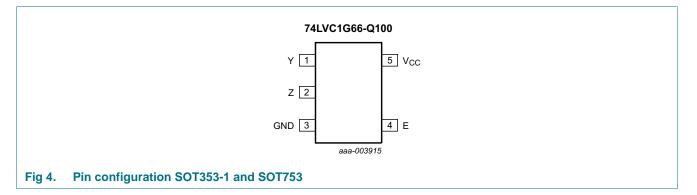
5. Functional diagram





6. Pinning information

6.1 Pinning



6.2 Pin description

Table 3.	Pin description	
Symbol	Pin	Symbol
Y	1	independent input or output
Z	2	independent output or input
GND	3	ground (0 V)
E	4	enable input (active HIGH)
V _{CC}	5	supply voltage

7. Functional description

Table 4. Function table^[1]

Input E	Switch
L	OFF-state
Н	ON-state

[1] H = HIGH voltage level; L = LOW voltage level

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

					,
Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+6.5	V
VI	input voltage		<u>[1]</u> –0.5	+6.5	V
I _{IK}	input clamping current	$V_{\rm I}$ < –0.5 V or $V_{\rm I}$ > $V_{\rm CC}$ + 0.5 V	-50	-	mA
I _{SK}	switch clamping current	$V_{\rm I}$ < –0.5 V or $V_{\rm I}$ > $V_{\rm CC}$ + 0.5 V	-	±50	mA
V _{SW}	switch voltage	enable and disable mode	<mark>[2]</mark> –0.5	V _{CC} + 0.5	V
I _{SW}	switch current	V_{SW} > –0.5 V or V_{SW} < V_{CC} + 0.5 V	-	±50	mA
I _{CC}	supply current		-	100	mA
I _{GND}	ground current		-100	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	T_{amb} = -40 ° C to +125 °C	<u>[3]</u> _	250	mW

[1] The minimum input voltage rating may be exceeded if the input current rating is observed.

[2] The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed.

[3] For TSSOP5 and SC-74A packages: above 87.5 °C the value of Ptot derates linearly with 4.0 mW/K.

For XSON6 packages: above 118 °C the value of Ptot derates linearly with 7.8 mW/K.

9. Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		1.65	-	5.5	V
VI	input voltage		0	-	5.5	V
V _{SW}	switch voltage		[1] 0	-	V _{CC}	V
T _{amb}	ambient temperature		-40	-	+125	°C
$\Delta t/\Delta V$ input transition rise and		V_{CC} = 1.65 V to 2.7 V	[2] _	-	20	ns/V
	fall rate	V_{CC} = 2.7 V to 5.5 V	[2] _	-	10	ns/V

[1] To avoid sinking GND current from terminal Z when switch current flows in terminal Y, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal Z, no GND current flows from terminal Y. In this case, there is no limit for the voltage drop across the switch.

[2] Applies to control signal levels.

10. Static characteristics

Table 7. Static characteristics

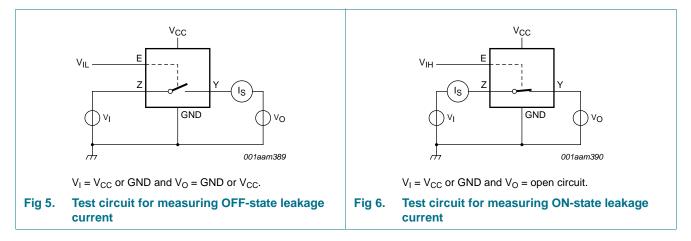
At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		-40 °	°C to +8	S5 ℃	-40 °C to	• +125 °C	Unit
				Min	Typ[1]	Мах	Min	Max	
V _{IH}	HIGH-level	V _{CC} = 1.65 V to 1.95 V		0.65V _{CC}	-	-	0.65V _{CC}	-	V
	input voltage	V_{CC} = 2.3 V to 2.7 V		1.7	-	-	1.7	-	V
		V _{CC} = 2.7 V to 3.6 V		2.0	-	-	2.0	-	V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		$0.7 V_{CC}$	-	-	$0.7V_{CC}$	-	V
V _{IL}	LOW-level	V _{CC} = 1.65 V to 1.95 V		-	-	$0.35V_{CC}$	-	$0.35V_{CC}$	V
	input voltage	V_{CC} = 2.3 V to 2.7 V		-	-	0.7	-	0.7	V
	LOW-level input voltage input leakage current OFF-state leakage current ON-state leakage current supply current	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		-	-	0.8	-	0.8	V
		V_{CC} = 4.5 V to 5.5 V		-	-	$0.3V_{CC}$	-	$0.3V_{CC}$	V
l _l		pin E; $V_1 = 5.5$ V or GND; $V_{CC} = 0$ V to 5.5 V	2]	-	±0.1	±5	-	±100	μΑ
I _{S(OFF)}	leakage	$V_{CC} = 5.5 \text{ V}; \text{ see } Figure 5$	<u>2]</u>	-	±0.1	±5	-	±200	μΑ
I _{S(ON)}	leakage	$V_{CC} = 5.5 \text{ V}; \text{ see } Figure 6$	<u>2]</u>	-	±0.1	±5	-	±200	μΑ
I _{CC}		$V_{I} = 5.5 V \text{ or GND};$ $V_{SW} = GND \text{ or } V_{CC};$ $V_{CC} = 1.65 V \text{ to } 5.5 V$	2]	-	0.1	10	-	200	μA
ΔI_{CC}	additional supply current	pin E; $V_1 = V_{CC} - 0.6 V$; $V_{SW} = GND \text{ or } V_{CC}$; $V_{CC} = 5.5 V$	2]	-	5	500	-	5000	μA
Cı	input capacitance			-	2.0	-	-	-	pF
$C_{S(\text{OFF})}$	OFF-state capacitance			-	6.5	-	-	-	pF
$C_{S(ON)}$	ON-state capacitance			-	11	-	-	-	pF

[1] All typical values are measured at T_{amb} = 25 °C.

[2] These typical values are measured at V_{CC} = 3.3 V.

10.1 Test circuits



10.2 ON resistance

Table 8.ON resistance

At recommended operating conditions; voltages are referenced to GND (ground 0 V); for graphs see Figure 8 to Figure 13.

Symbol	Parameter	Conditions	-40	°C to +8	85 °C	–40 °C to +125 °C		Unit
			Min	Typ <mark>[1]</mark>	Max	Min	Max	
R _{ON(peak)}	ON resistance (peak)	$V_I = GND$ to V_{CC} ; see <u>Figure 7</u>						
		I _{SW} = 4 mA; V _{CC} = 1.65 V to 1.95 V	-	34.0	130	-	195	Ω
		I_{SW} = 8 mA; V_{CC} = 2.3 V to 2.7 V	-	12.0	30	-	45	Ω
		I_{SW} = 12 mA; V_{CC} = 2.7 V	-	10.4	25	-	38	Ω
		I_{SW} = 24 mA; V_{CC} = 3.0 V to 3.6 V	-	7.8	20	-	30	Ω
		I_{SW} = 32 mA; V_{CC} = 4.5 V to 5.5 V	-	6.2	15	-	23	Ω
R _{ON(rail)}	ON resistance (rail)	$V_I = GND$; see Figure 7						
		I _{SW} = 4 mA; V _{CC} = 1.65 V to 1.95 V	-	8.2	18	-	27	Ω
		I_{SW} = 8 mA; V_{CC} = 2.3 V to 2.7 V	-	7.1	16	-	24	Ω
		I_{SW} = 12 mA; V_{CC} = 2.7 V	-	6.9	14	-	21	Ω
		I_{SW} = 24 mA; V_{CC} = 3.0 V to 3.6 V	-	6.5	12	-	18	Ω
		I_{SW} = 32 mA; V_{CC} = 4.5 V to 5.5 V	-	5.8	10	-	15	Ω
		$V_I = V_{CC}$; see <u>Figure 7</u>						
		I _{SW} = 4 mA; V _{CC} = 1.65 V to 1.95 V	-	10.4	30	-	45	Ω
		I_{SW} = 8 mA; V_{CC} = 2.3 V to 2.7 V	-	7.6	20	-	30	Ω
		I_{SW} = 12 mA; V_{CC} = 2.7 V	-	7.0	18	-	27	Ω
		I_{SW} = 24 mA; V_{CC} = 3.0 V to 3.6 V	-	6.1	15	-	23	Ω
		I_{SW} = 32 mA; V_{CC} = 4.5 V to 5.5 V	-	4.9	10	-	15	Ω

Bilateral switch

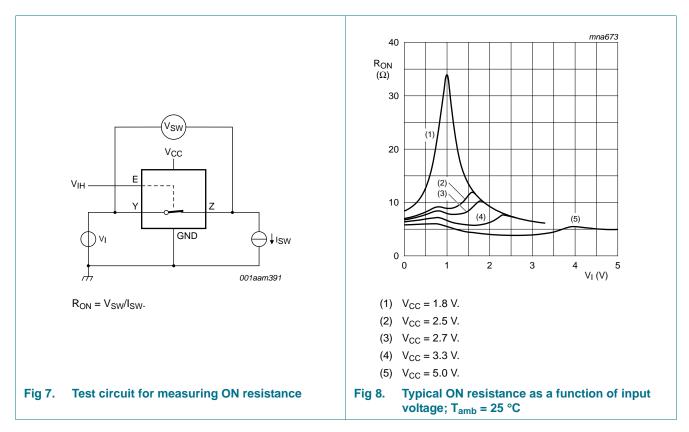
Symbol Parameter		Conditions		–40 °C t		S ℃	–40 °C to +125 °C		Unit
				Min	Typ[1]	Max	Min	Max	
R _{ON(flat)}	ON resistance	$V_I = GND$ to V_{CC}	[2]						
(flatness)	(flatness)	I _{SW} = 4 mA; V _{CC} = 1.65 V to 1.95 V		-	26.0	-	-	-	Ω
		I_{SW} = 8 mA; V_{CC} = 2.3 V to 2.7 V		-	5.0	-	-	-	Ω
		I_{SW} = 12 mA; V_{CC} = 2.7 V		-	3.5	-	-	-	Ω
		I_{SW} = 24 mA; V_{CC} = 3.0 V to 3.6 V		-	2.0	-	-	-	Ω
		I_{SW} = 32 mA; V_{CC} = 4.5 V to 5.5 V		-	1.5	-	-	-	Ω

Table 8. ON resistance ...continued

At recommended operating conditions; voltages are referenced to GND (ground 0 V); for graphs see Figure 8 to Figure 13.

[1] Typical values are measured at T_{amb} = 25 $^\circ C$ and nominal $V_{CC}.$

[2] Flatness is defined as the difference between the maximum and minimum value of ON resistance measured at identical V_{CC} and temperature.



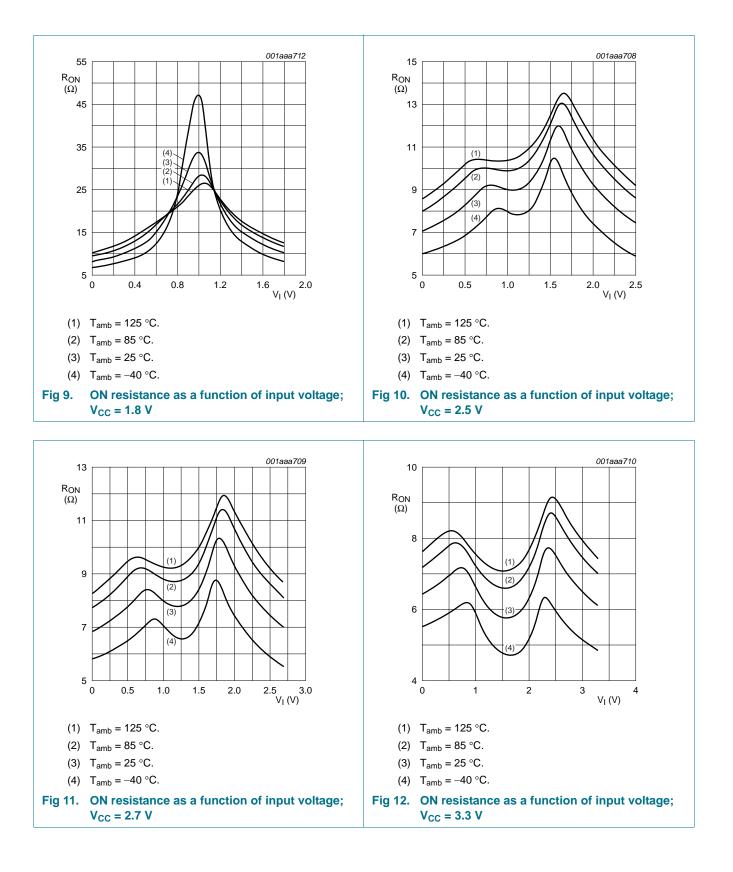
10.3 ON resistance test circuit and graphs

74LVC1G66_Q100

NXP Semiconductors

74LVC1G66-Q100

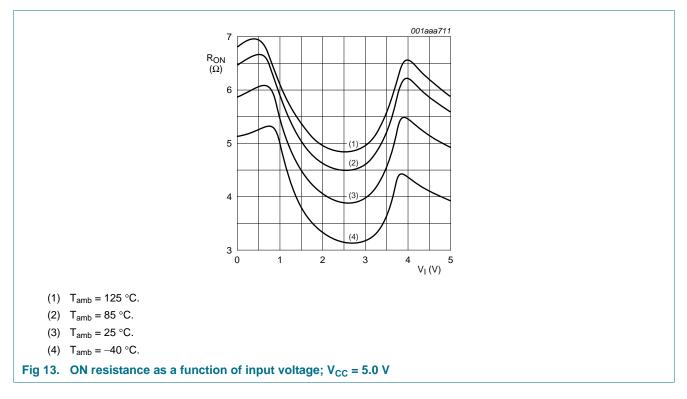
Bilateral switch



NXP Semiconductors

74LVC1G66-Q100

Bilateral switch



11. Dynamic characteristics

Table 9. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 16.

Symbol	Parameter	Conditions		-40	°C to +8	5 °C	–40 °C to	–40 °C to +125 °C		
				Min	Typ[1]	Max	Min	Max		
t _{pd}	propagation delay	Y to Z or Z to Y; see <u>Figure 14</u>	<u>[2][3]</u>							
		V_{CC} = 1.65 V to 1.95 V		-	0.8	2.0	-	3.0	ns	
		V_{CC} = 2.3 V to 2.7 V		-	0.4	1.2	-	2.0	ns	
		$V_{CC} = 2.7 V$		-	0.4	1.0	-	1.5	ns	
		V_{CC} = 3.0 V to 3.6 V		-	0.3	0.8	-	1.5	ns	
		V_{CC} = 4.5 V to 5.5 V		-	0.2	0.6	-	1.0	ns	
t _{en}	enable time	E to Y or Z; see Figure 15	[4]							
		V_{CC} = 1.65 V to 1.95 V		1.0	5.3	12	1.0	15.5	ns	
		V_{CC} = 2.3 V to 2.7 V		1.0	3.0	6.5	1.0	8.5	ns	
		$V_{CC} = 2.7 V$		1.0	2.6	6.0	1.0	8.0	ns	
		V_{CC} = 3.0 V to 3.6 V		1.0	2.5	5.0	1.0	6.5	ns	
		V_{CC} = 4.5 V to 5.5 V		1.0	1.9	4.2	1.0	5.5	ns	

Bilateral switch

Symbol	Parameter	Conditions		-40) °C to +8	5 °C	–40 °C to	o +125 ℃	Unit
				Min	Typ[1]	Max	Min	Max	
^t dis	disable time	E to Y or Z; see Figure 15	[5]				•	1	
		V_{CC} = 1.65 V to 1.95 V		1.0	4.2	10	1.0	13	ns
		V_{CC} = 2.3 V to 2.7 V		1.0	2.4	6.9	1.0	9.0	ns
		$V_{CC} = 2.7 V$		1.0	3.6	7.5	1.0	9.5	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$		1.0	3.4	6.5	1.0	8.5	ns
		V_{CC} = 4.5 V to 5.5 V		1.0	2.5	5.0	1.0	6.5	ns
1 D	power dissipation capacitance	$C_L = 50 \text{ pF}; f_i = 10 \text{ MHz};$ V _I = GND to V _{CC}	<u>[6]</u>						
		$V_{CC} = 2.5 V$		-	9.8	-	-	-	pF
		$V_{CC} = 3.3 V$		-	12.0	-	-	-	pF
		V _{CC} = 5.0 V		-	17.3	-	-	-	pF

Table 9. Dynamic characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 16.

[1] Typical values are measured at T_{amb} = 25 °C and nominal V_{CC}.

[2] t_{pd} is the same as t_{PLH} and t_{PHL}

[3] propagation delay is the calculated RC time constant of the typical ON resistance of the switch and the specified capacitance when driven by an ideal voltage source (zero output impedance).

[4] t_{en} is the same as t_{PZH} and t_{PZL}

[5] t_{dis} is the same as t_{PLZ} and t_{PHZ}

[6] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_{D} = C_{PD} \times V_{CC}^{2} \times f_{i} \times N + \Sigma \{ (C_{L} + C_{S(ON)}) \times V_{CC}^{2} \times f_{o} \} \text{ where:}$

 $f_i = input frequency in MHz;$

 $f_o = output frequency in MHz;$

 C_L = output load capacitance in pF;

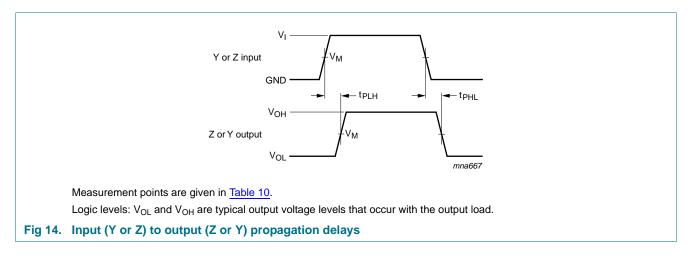
C_{S(ON)} = maximum ON-state switch capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

 Σ {(C_L + C_{S(ON)}) × V_{CC}² × f_o} = sum of the outputs.

11.1 Waveforms and test circuit



74LVC1G66_Q100 Product data sheet

Bilateral switch

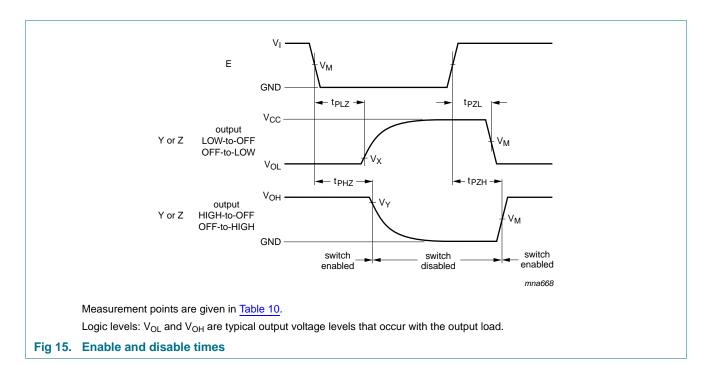
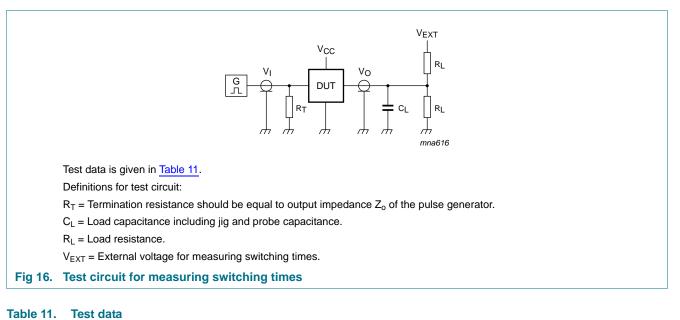


Table 10. Measurement points

Supply voltage	Input	Output		
V _{cc}	V _M	V _M	V _X	V _Y
1.65 V to 1.95 V	$0.5V_{CC}$	$0.5V_{CC}$	V _{OL} + 0.15 V	V _{OH} – 0.15 V
2.3 V to 2.7 V	$0.5V_{CC}$	$0.5V_{CC}$	V _{OL} + 0.15 V	V _{OH} – 0.15 V
2.7 V	1.5 V	1.5 V	V _{OL} + 0.3 V	$V_{OH} - 0.3 \ V$
3.0 V to 3.6 V	1.5 V	1.5 V	V _{OL} + 0.3 V	$V_{OH} - 0.3 V$
4.5 V to 5.5 V	$0.5V_{CC}$	$0.5V_{CC}$	V _{OL} + 0.3 V	$V_{OH} - 0.3 V$

Bilateral switch



Supply voltage	Input	Input		Load		V _{EXT}		
V _{cc}	VI	t _r , t _f	CL	RL	t _{PLH} , t _{PHL}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}	
1.65 V to 1.95 V	V _{CC}	\leq 2.0 ns	30 pF	1 kΩ	open	GND	2V _{CC}	
2.3 V to 2.7 V	V _{CC}	\leq 2.0 ns	30 pF	500 Ω	open	GND	2V _{CC}	
2.7 V	2.7 V	\leq 2.5 ns	50 pF	500 Ω	open	GND	6 V	
3.0 V to 3.6 V	2.7 V	\leq 2.5 ns	50 pF	500 Ω	open	GND	6 V	
4.5 V to 5.5 V	V _{CC}	\leq 2.5 ns	50 pF	500 Ω	open	GND	2V _{CC}	

11.2 Additional dynamic characteristics

Table 12. Additional dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); $T_{amb} = 25$ °C.

		•	of anno			
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
THD	total harmonic distortion	$R_L = 10 \text{ k}\Omega; C_L = 50 \text{ pF}; f_i = 1 \text{ kHz};$ see Figure 17				
		V _{CC} = 1.65 V	-	0.032	-	%
		$V_{CC} = 2.3 V$	-	0.008	-	%
		$V_{CC} = 3.0 V$	-	0.006	-	%
		V _{CC} = 4.5 V	-	0.001	-	%
		R_L = 10 k Ω ; C_L = 50 pF; f _i = 10 kHz; see <u>Figure 17</u>				
		V _{CC} = 1.65 V	-	0.068	-	%
		V _{CC} = 2.3 V	-	0.009	-	%
		$V_{CC} = 3.0 V$	-	0.008	-	%
		$V_{CC} = 4.5 V$	-	0.006	-	%

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Table 12. Additional dynamic characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); $T_{amb} = 25$ °C.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f _(-3dB)	–3 dB frequency response	R_L = 600 Ω; C_L = 50 pF; see Figure 18				
		V _{CC} = 1.65 V	-	135	-	MHz
		$V_{CC} = 2.3 V$	-	145	-	MHz
		$V_{CC} = 3.0 V$	-	150	-	MHz
		$V_{CC} = 4.5 V$	-	155	-	MHz
		$R_L = 50 \Omega; C_L = 5 pF; see Figure 18$				
		V _{CC} = 1.65 V	-	> 500	-	MHz
		$V_{CC} = 2.3 V$	-	> 500	-	MHz
		$V_{CC} = 3.0 V$	-	> 500	-	MHz
		$V_{CC} = 4.5 V$	-	> 500	-	MHz
		$R_L = 50 \Omega$; $C_L = 10 pF$; see Figure 18				
		V _{CC} = 1.65 V	-	200	-	MHz
		$V_{CC} = 2.3 V$	-	350	-	MHz
		$V_{CC} = 3.0 V$	-	410	-	MHz
		$V_{CC} = 4.5 V$	-	440	-	MHz
α _{iso}	isolation (OFF-state)	R_L = 600 Ω; C_L = 50 pF; f_i = 1 MHz; see Figure 19				
		V _{CC} = 1.65 V	-	-46	-	dB
		$V_{CC} = 2.3 V$	-	-46	-	dB
		$V_{CC} = 3.0 V$	-	-46	-	dB
		$V_{CC} = 4.5 V$	-	-46	-	dB
		$R_L = 50 \Omega; C_L = 5 pF; f_i = 1 MHz;$ see Figure 19				
		V _{CC} = 1.65 V	-	-37	-	dB
		$V_{CC} = 2.3 V$	-	-37	-	dB
		$V_{CC} = 3.0 V$	-	-37	-	dB
		$V_{CC} = 4.5 V$	-	-37	-	dB
V _{ct}	crosstalk voltage	between digital input and switch; $R_L = 600 \Omega$; $C_L = 50 pF$; $f_i = 1 MHz$; $t_r = t_f = 2 ns$; see Figure 20				
		V _{CC} = 1.65 V	-	69	-	mV
		$V_{CC} = 2.3 V$	-	87	-	mV
		V _{CC} = 3.0 V	-	156	-	mV
		V _{CC} = 4.5 V		302	-	mV

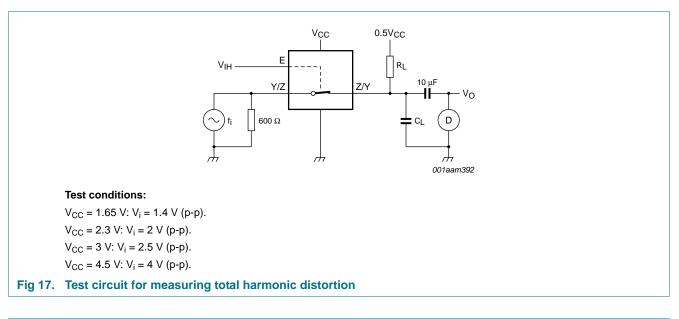
Bilateral switch

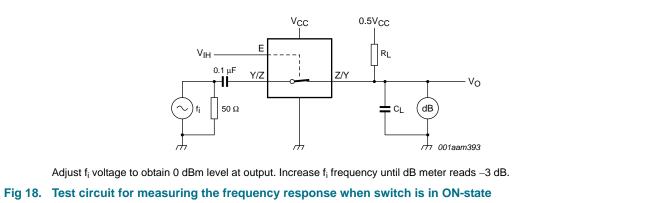
Table 12. Additional dynamic characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); $T_{amb} = 25$ °C.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Q _{inj} charge injection	charge injection	$ C_L = 0.1 \text{ nF; } V_{gen} = 0 \text{ V; } R_{gen} = 0 \Omega; $				
		V _{CC} = 1.8 V	-	3.3	-	рС
		$V_{CC} = 2.5 V$	-	4.1	-	рС
		$V_{CC} = 3.3 V$	-	5.0	-	рС
		$V_{CC} = 4.5 V$	-	6.4	-	рС
		$V_{CC} = 5.5 V$	-	7.5	-	рС

11.3 Test circuits

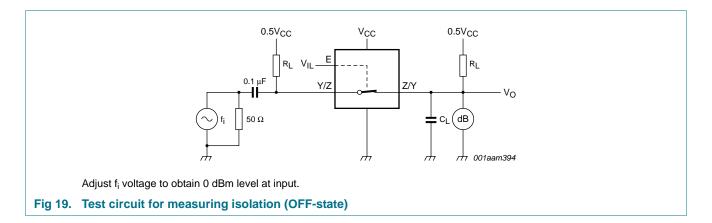


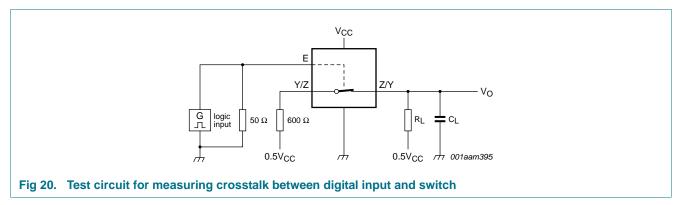


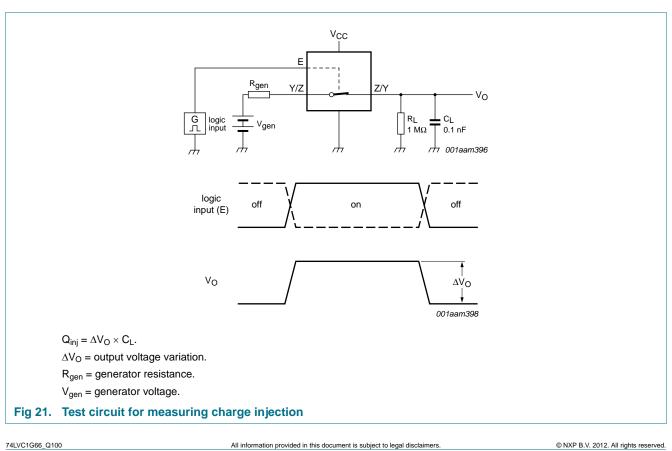
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Bilateral switch







Bilateral switch

12. Package outline

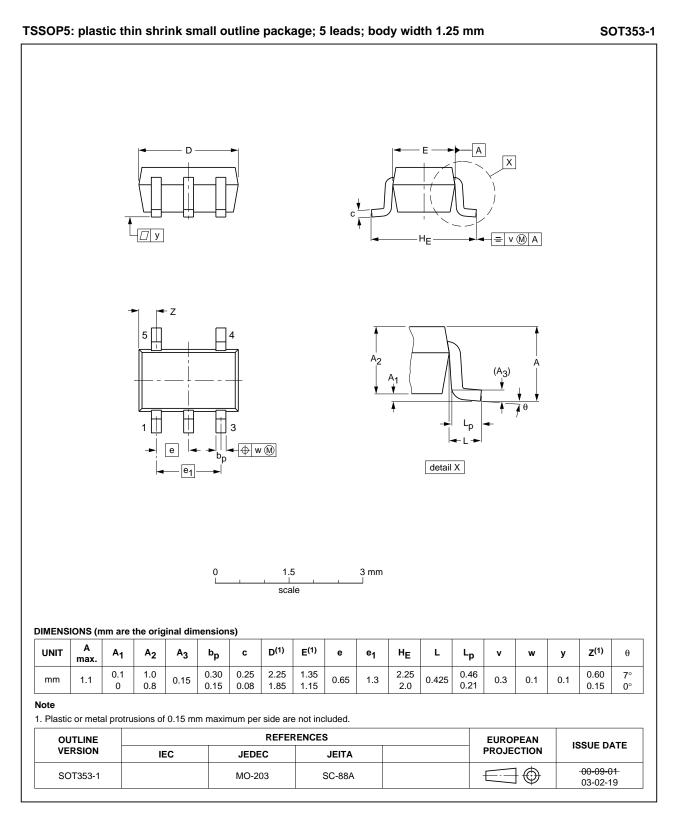


Fig 22. Package outline SOT353-1 (TSSOP5)

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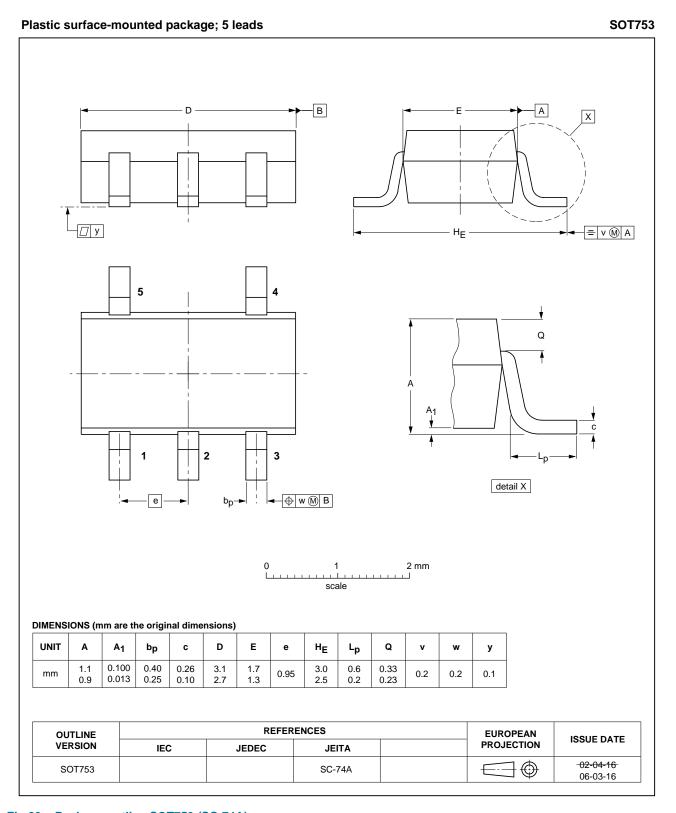


Fig 23. Package outline SOT753 (SC-74A)

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13. Abbreviations

Table 13.	3. Abbreviations		
Acronym	Description		
CMOS	Complementary Metal Oxide Semiconductor		
TTL	Transistor-Transistor Logic		
HBM	Human Body Model		
ESD	ElectroStatic Discharge		
MM	Machine Model		
DUT	Device Under Test		
MIL	Military		

14. Revision history

Table 14. Revision his	Revision history				
Document ID	Release date	Data sheet status	Change notice	Supersedes	
74LVC1G66_Q100 v.1	20120801	Product data sheet	-	-	

15. Legal information

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Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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